

### **Description**

The HXY4020NF uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

# **General Features**

V<sub>DS</sub> = 40V I<sub>D</sub> =30 A

 $R_{DS(ON)}$  < 23m $\Omega$  @  $V_{GS}$ =10V

 $V_{DS} = -40V I_{D} = -20A$ 

 $R_{DS(ON)}$  <  $42m\Omega$  @  $V_{GS}$ =10V

### **Application**

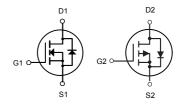
**Battery protection** 

Load switch

Uninterruptible power supply

#### G2 S2 G1 D2 D2 D1 D1 FS1 Pin 1

#### DFN5X6-8L



N-Channel

P-Channel

## **Package Marking and Ordering Information**

Product ID	Pack	Marking	Qty(PCS)
HXY4020NF	DFN5X6-8L	4020 XXX YYYY	5000

### Absolute Maximum Ratings (T<sub>c</sub>=25 ℃ unless otherwise noted)

		Ra	ting	
Symbol	Parameter	N-Channel	P-Channel	Units
V <sub>DS</sub>	Drain-Source Voltage	40	-40	V
Vgs	Gate-Source Voltage	±20	±20	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	30	-20	А
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	18	-16	A
Ідм	Pulsed Drain Current <sup>2</sup>	46	-40	Α
EAS	Single Pulse Avalanche Energy <sup>3</sup>	28	66	mJ
las	Avalanche Current	17.8	- 27.2	Α
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation⁴	10.8	10.8	W
P <sub>D</sub> @T <sub>A</sub> =100°C	Total Power Dissipation <sup>4</sup>	5	4.8	W
Тѕтс	Storage Temperature Range	-55 to 150	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C
R <sub>θ</sub> JA	Thermal Resistance Junction-Ambient <sup>1</sup>		62	°C/W
R <sub>θ</sub> JC	Thermal Resistance Junction-Case <sup>1</sup>		5	°C/W



## N-Channel Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	40			V	
△BV <sub>DSS</sub> /△T <sub>J</sub>	BVDSS Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.034		V/°C	
D-aran	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V , I <sub>D</sub> =12A		19	23	mΩ	
R <sub>DS(ON)</sub>		V <sub>GS</sub> =4.5V , I <sub>D</sub> =10A		24	30		
V <sub>GS(th)</sub>	Gate Threshold Voltage	V V I 250	1.0	1.5	2.5	V	
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=250uA$		-4.56		mV/°C	
	Dunin Course Looks as Course	V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA	
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5		
Igss	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =12A		8		S	
$R_g$	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.6	5.2	Ω	
Qg	Total Gate Charge (4.5V)			5.5			
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> =20V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =12A		1.25		nC	
Q <sub>gd</sub>	Gate-Drain Charge			2.5			
T <sub>d(on)</sub>	Turn-On Delay Time			8.9			
Tr	Rise Time	$V_{DD}$ =20V , $V_{GS}$ =10V , $R_{G}$ =3.3 $\Omega$		2.2		20	
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =1A		41		ns	
T <sub>f</sub>	Fall Time			2.7			
Ciss	Input Capacitance			593			
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		76		pF	
Crss	Reverse Transfer Capacitance			56			

### **Diode Characteristics**

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
Is	Continuous Source Current <sup>1,5</sup>	V- V- OV Force Current			23	Α
Ism	Pulsed Source Current <sup>2,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			46	Α
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1.2	V

#### Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\,\leq\,300\text{us}$  , duty cycle  $\,\leq\,2\%$
- 3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH,  $I_{AS}$ =17.8A
- 4.The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



# P-Channel Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-40			V
△BV <sub>DSS</sub> /△T <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =-1mA		-0.012		V/°C
D	Static Drain-Source On-Resistance <sup>2</sup>	$V_{GS}$ =-10 $V$ , $I_{D}$ =-8 $A$		34	42	<b>m</b> O
Rds(on)		V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-4A		67	84	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	Vgs=Vps . lp =-250uA	-1.0	-1.6	-2.5	V
△VGS(th)	V <sub>GS(th)</sub> Temperature Coefficient	VGS=VDS , ID =-250UA		4.32		mV/°C
lana	Drain Source Leakage Current	V <sub>DS</sub> =-32V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-32V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm 20V$ , $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-8A		12.6		S
$R_g$	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		13	16	Ω
$Q_g$	Total Gate Charge (-4.5V)			9		
$Q_gs$	Gate-Source Charge	V <sub>DS</sub> =-20V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-12A		2.54		nC
Q <sub>gd</sub>	Gate-Drain Charge			3.1		
T <sub>d(on)</sub>	Turn-On Delay Time			19.2		
Tr	Rise Time	$V_{DD}$ =-15 $V$ , $V_{GS}$ =-10 $V$ , $R_{G}$ =3.3 $\Omega$ ,		12.8		
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =-1A		48.6		ns
Tf	Fall Time			4.6		
C <sub>iss</sub>	Input Capacitance			1004		
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		108		pF
Crss	Reverse Transfer Capacitance			80		

## **Diode Characteristics**

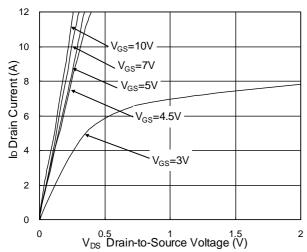
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current <sup>1,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-20	Α
I <sub>SM</sub>	Pulsed Source Current <sup>2,5</sup>	VG=VD=0V, Force Current			-40	Α
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C	-		-1	V

#### Note

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%
- 3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =-25V,  $V_{GS}$ =-10V, L=0.1mH,  $I_{AS}$ =-27.2A
- 4. The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



## **N-Channel Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

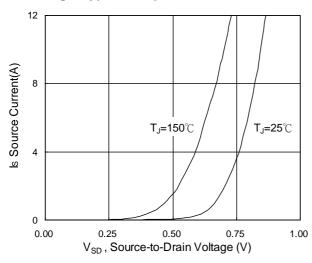


Fig.3 Forward Characteristics of Reverse

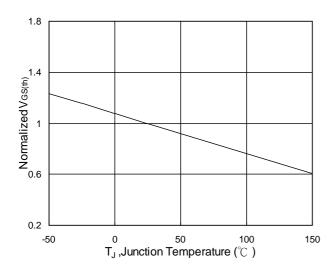


Fig.5 Normalized V<sub>GS(th)</sub> vs. T<sub>J</sub>

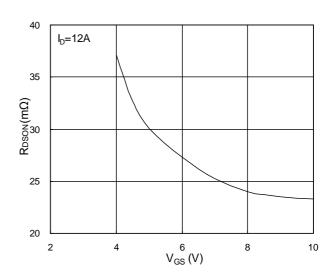


Fig.2 On-Resistance vs. G-S Voltage

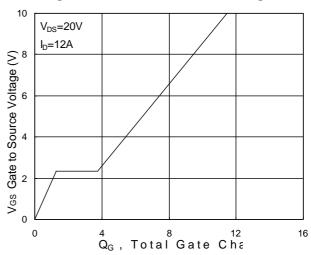


Fig.4 Gate-Charge Characteristics

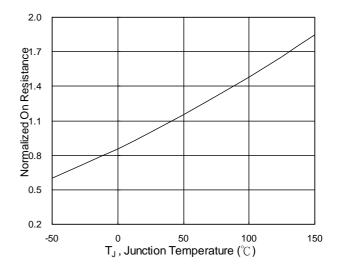
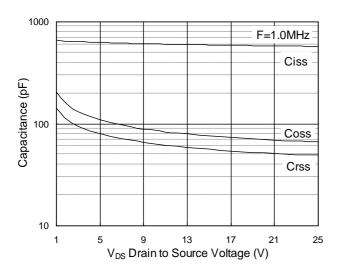


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



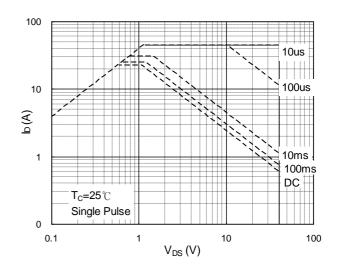


Fig.7 Capacitance

Fig.8 Safe Operating Area

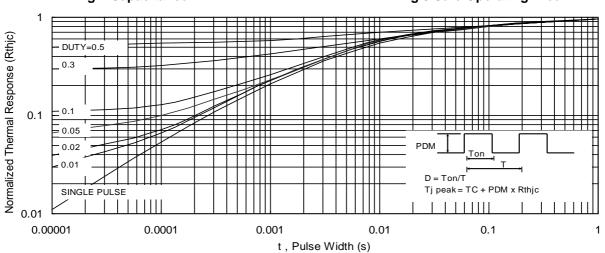
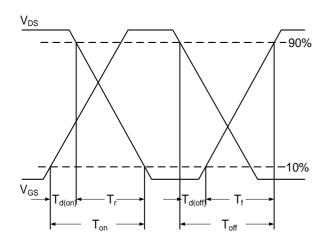


Fig.9 Normalized Maximum Transient Thermal Impedance



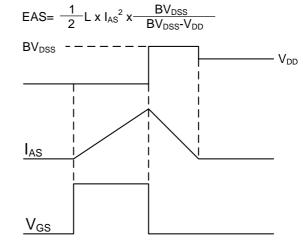


Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Switching Wave



## **P-Channel Typical Characteristics**

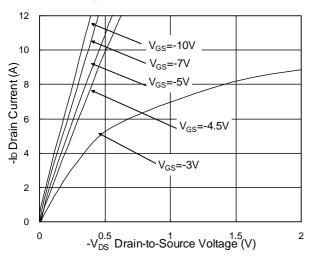


Fig.1 Typical Output Characteristics

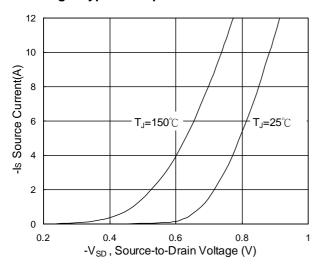


Fig.3 Forward Characteristics of Reverse

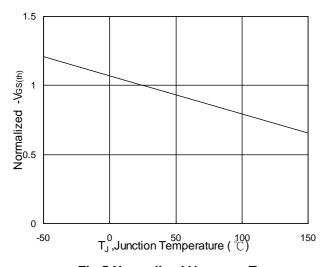


Fig.5 Normalized  $V_{\text{GS(th)}}$  v.s  $T_{\text{J}}$ 

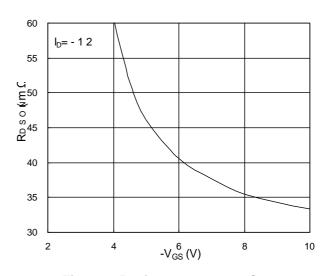


Fig.2 On-Resistance v.s Gate-Source

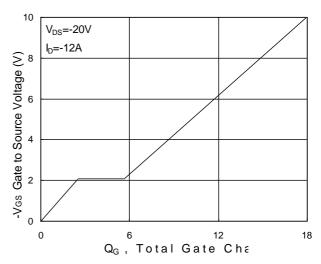


Fig.4 Gate-Charge Characteristics

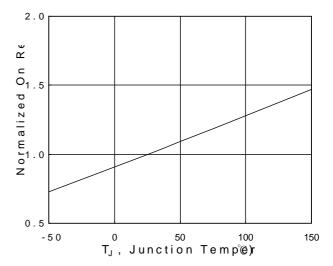
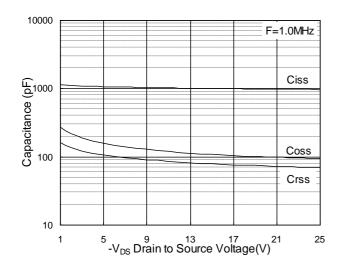


Fig.6 Normalized  $R_{DSON}$  v.s  $T_J$ 



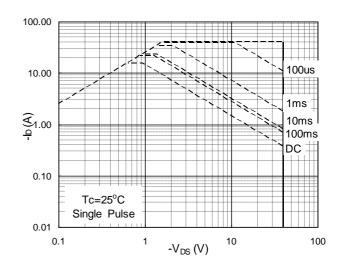


Fig.7 Capacitance

Fig.8 Safe Operating Area

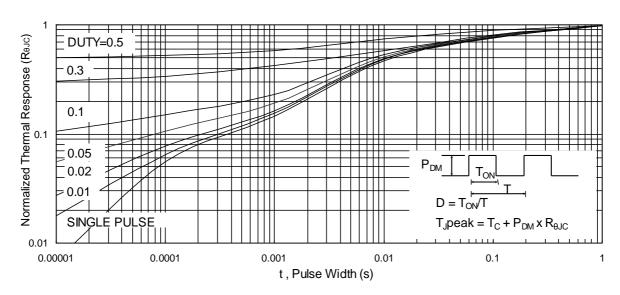


Fig.9 Normalized Maximum Transient Thermal Impedance

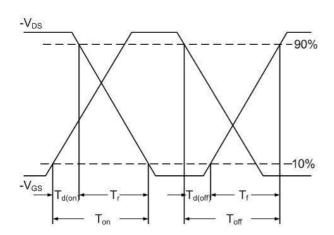


Fig.10 Switching Time Waveform

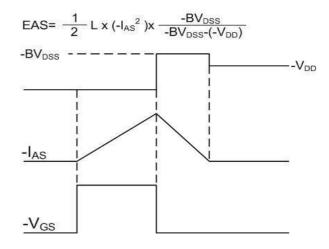
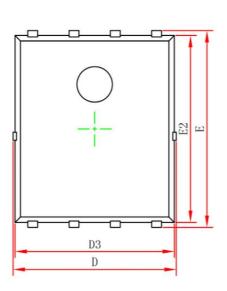
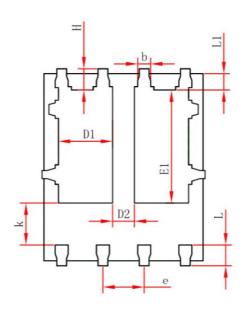


Fig.11 Unclamped Inductive Waveform



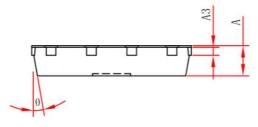
# **DFN5X6-8L Package Information**





**Top View** 

**Bottom View** 



**Side View** 

Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	0.900	1.000	0.035	0.039
A3	0.154	IREF.	0.006	REF.
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	1.470	1.870	0.058	0.074
D2	0.470	0.870	0.019	0.034
E1	3.375	3.575	0.133	0.141
D3	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
е	1.270	1.270TYP.		TYP.
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
Н	0.574	0.726	0.023	0.029
θ	10°	12°	10°	12°



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